

Search Notes

Application/Control No.

10/553,907

Examiner

/BINH K. TIEU/

Applicant(s)/Patent under
Reexamination

WAHL ET AL.

Art Unit

2614

SEARCHED

Class	Subclass	Date	Examiner
379	1.01	1/10/2008	BKT
↓	1.03	↓	↓
	9		
	9.02		
	9.04		
	10.01		
	10.03		
	15.01		
	22.02		
	23-24		
	27.01		
	29.01		
	32.04		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
WEST DATABASES SEARCH	1/7/2008	BKT